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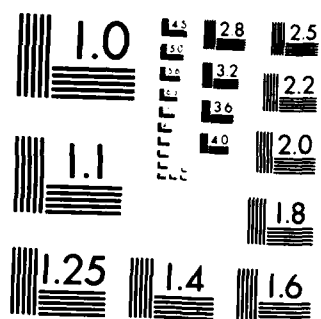
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Determination of Structural Parameters from EXAFS:

Application to Solutions and Catalysts

by

Donald R. Sandstrom

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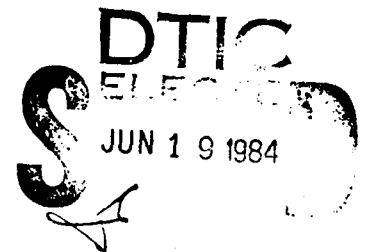
Proceedings of the Workshop on EXAFS Data

Analysis in Disordered Systems

Parma, Italy, October 5-7, 1981

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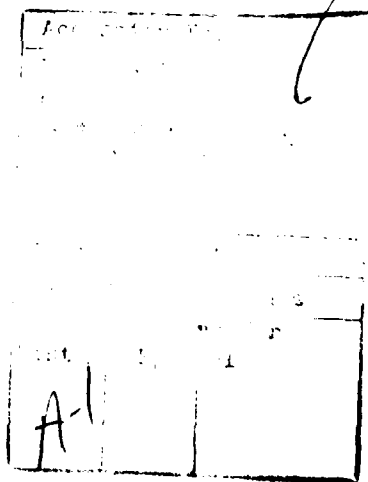
Determination of structural parameters from EXAFS: Application
to solutions and catalysts

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Abstract

A review is presented of applications of Extended X-Ray
Absorption Fine Structure (EXAFS) spectroscopy to the determina-
tion of structural detail in inorganic solutions and supported
metal catalyst particles. Similarities in these applications
are noted and the possible role of disorder on the reliability
of the EXAFS results is discussed. A brief summary of data
analysis procedures is presented with examples.



INTRODUCTION

The scope of the present paper is to review briefly the application of EXAFS spectroscopy to the study of local order and structure in inorganic solutions, and to the study of supported metal catalysts. These areas, while weakly related in terms of application, have common factors relative to their examination by EXAFS. These include a comparatively large degree of disorder, coordination of metal atoms both by low-Z scattering atoms such as O and C and higher-Z atoms such as Br and Pt, and by the need to measure the x-ray absorption spectrum for the metal atoms at low concentration in a low-Z matrix.

In addition to the above review, an overview will be given of the analysis procedures appropriate for these systems. This will include the steps involved in the extraction of the EXAFS oscillations from the raw experimental data, as well as analysis of the EXAFS spectrum for structural detail. Particular attention will be given to evaluation of the phase information present in the EXAFS spectrum, and handling of the k-dependent phase functions, especially for high-Z scatterers such as Pt.

APPLICATIONS TO SOLUTIONS

The past few years have seen very significant advances in our understanding of structure present in aqueous solutions. These have come partly as a result of theoretical studies¹ and partly as a result of the application of experimental techniques of which EXAFS is one. The experimental methods give direct evidence for the existence of a first hydration zone such as described by Frank and Wen,² with evidence for a second zone in many cases.

Historically, the experimental study of solutions employed optical and resonance spectroscopy and thermodynamic measurements. Since the 1960's these have been supplemented by x-ray and neutron diffraction methods.³ The diffraction techniques have been strongly developed during the past decade, and now represent the principal methods in use. Although EXAFS spectroscopy was applied to a solution system as early as 1975,⁴ most contributions to our understanding of solutions from this source have come since 1978.

Because of the important role which x-ray and neutron diffraction play in current research, the contributions of EXAFS spectroscopy can best be discussed in the context of these two techniques. A comprehensive review of diffraction methods has recently been given by Neilson and Enderby.³ Both techniques measure the differential scattering cross section $d\sigma/d\Omega$ as a function of the scattering vector or momentum transfer $k = (4\pi/\lambda)\sin(\theta/2)$, where the full range of k from very small values out to $\sim 15 \text{ \AA}^{-1}$ can be measured. Because the momentum transfer in the electron scattering involved in EXAFS is twice the conventionally displayed electron wave vector k , the above range of momentum transfer for the diffraction case can be compared to a momentum transfer range of $6 < 2k < 3.0 \text{ \AA}^{-1}$ for the typical EXAFS case. Loss of the low k data in the EXAFS case has been pointed out⁵ to be responsible for reduced ability to recover slowly varying portions of the radial distribution

functions from Fourier transforms of the EXAFS spectra, in contrast to the diffraction case.

Measured diffraction curves derive from a total structure factor that is a linear superposition of terms involving partial structure factors for each distinct atom-atom correlation present in the system. For example, a four component system such as MX_n dissolved in H_2O would involve ten partial structure factors. The challenge of unraveling details of the pertinent M-O, M-X or X-O coordinations from the data has been met with considerable success by modeling procedures, and in the case of neutron diffraction, by isotopic substitution methods.³ It should be noted that the availability of tunable synchrotron radiation offers the possibility of using the anomalous dispersion of the elements in the solution to attack this problem.⁶ With EXAFS, one measures a superposition of the coordinations involving each accessible element in turn because of the spectroscopic separation of the absorption edges of the elements. The resulting element specificity is a key advantage in that the modeling of the EXAFS spectra is very much simplified compared to the diffraction case, especially when no structural evidence is available in advance.

Diffraction techniques become increasingly difficult to apply when concentration is below the range 0.1 - 1.0 M, because of the then overwhelming effect of the solvent-solvent correlations. At lower concentrations, EXAFS has considerable advantage, as fluorescence detection techniques can extend detectability to 100 ppm or below.⁷

The first applications of EXAFS spectroscopy to solution studies emphasized hydrated ions at low concentrations in aqueous solutions. These included the work of Eisenberger and Kincaid⁴ and Sandstrom et al.^{8,9} The primary objective of each of these studies was the determination of bond lengths to water molecules in the first hydration spheres of the cations or anions. These results are summarized in Table I.

In the first study shown in Table I, bond length was estimated directly from the wavelength of the EXAFS oscillations in k-space by applying a correction factor for the k-dependent phase function obtained from a reference material. The second study proceeded similarly, but the correction was applied to the position of the peak in the Fourier transform of the EXAFS oscillations. In the work reported in Ref. 9, bond lengths were obtained by a phase fitting method that will be described in more detail below. Where applicable, close agreement was found between the bond lengths shown in Table I and results from x-ray diffraction studies.

Subsequent to the above studies, a major area of application of EXAFS spectroscopy has been to the concentrated I-II electrolytes. These systems have simultaneously received considerable attention from workers employing both x-ray and neutron diffraction, as well as Raman spectroscopy. Specifically, several workers have studied the concentrated chlorides and bromides of Ni, Cu, and Zn in aqueous solution. For these systems, the formation of complexes containing direct metal-halogen bonds as well as metal-water coordination has been postulated. In addition, evidence for longer range cation-cation ordering similar to that in the crystalline salt has been presented. A summary of recent evidence for these systems from all applicable techniques is presented in Table II.

The results for the NiCl solutions by the diffraction techniques and EXAFS appear at first sight to be in good agreement that the first coordination sphere of Ni^{2+} is fully hydrated. This statement must, however, be somewhat qualified because of real sensitivity limitations to minority species that exist for all of these techniques. As Magini points out,¹¹ in a 50% mixture of $\text{Ni}(\text{H}_2\text{O})_6^{2+}$ and $\text{NiCl}(\text{H}_2\text{O})_5^+$ the average Cl^- coordination of the Ni^{2+} ion is only 8.3%. When it is considered that such a minority correlation must be extracted,

in the case of the diffraction techniques, not only from the background of the $\text{Ni-H}_2\text{O}$ correlations but also from the other correlations present in the solution, it should not be surprising that uncertainty exists with respect to minority species. The situation is somewhat better with EXAFS because only ligands of the x-ray absorbing atom effect the spectrum, but distinguishing among low-Z coordinating atoms at, say, the 10% level is not easy even when amplitude and phase functions are accurately known. The situation is helped somewhat in the case of NiCl_2 by the fact that the Ni-O and Ni-Cl phase functions differ by about π over the entire k-range of interest.¹⁴ It seems likely that the disagreement that stands between the diffraction-EXAFS results and the Raman results¹⁶ is due partly to this weak sensitivity to minority species coupled with a high sensitivity of Raman to Ni-Cl bonds. Nevertheless, the diffraction and EXAFS results for NiCl_2 would not admit NiCl_4^{2-} complexes at anything like the 50% level suggested by the Raman studies. Such a conclusion is supported by the one NiBr_2 study,¹⁵ which confirms the picture of full hydration of Ni^{2+} . Much of the ambiguity concerning the possible Ni-Cl bonding is removed from this case because of the very much larger backscattering amplitude and different behavior of the phase function for a Br scatterer.

Studies of CuCl_2 (Table II) all show evidence for direct Cu-Cl bonding, but disagree on the degree of coordination and its significance in terms of the presence of any long-range structures in these solutions. At highest concentrations, there does seem to be strong evidence for species, whether Cu monomers or polymers, having local coordination resembling that in the CuCl_2 crystal. This tendency appears to be enhanced when excess Cl^- ions are added to the solutions.¹⁷

Crystal-like local coordination seems to exist also in CuBr_2 at high concentrations. Here the question is the degree to which planer CuBr_4^{2-} units

link up to form chains as in the crystal. For Cu^{2+} ions in such units, the Br coordination would be 4. Thus the reported^{15,18} coordination number of 1.5 ± 0.5 would correspond to 25 - 50% of the Cu^{2+} ions in CuBr_4^{2-} units if the remaining Cu^{2+} ions are completely hydrated. For the same solution, it is easy to show that the average number of Cu^{2+} ions coordinating each Br^- ion would be just twice the fraction of Cu^{2+} ions occupying CuBr_4^{2-} units, independent of whether chains of any length are formed. This would correspond to 0.5 - 1.0 Cu^{2+} ion coordinating each Br^- ion on average, compared to 1.0 - 1.5 reported. This disagreement is not very significant, but could signal the presence of other Cu-Br containing species in these solutions besides CuBr_4^{2-} . Support for the idea of linked chains is given by the report of two unequal Br-Br bond distances in these solutions. The work of Fine¹⁹ shows evidence for more than one species having slightly differing Cu-Br bond lengths. Variation of the Br/Cu ratio by adding HBr produced no change in these bond lengths, but strongly affected the relative abundance of the two species. The species have been tentatively identified as $\text{CuBr}(\text{H}_2\text{O})_5^{2+}$ and $\text{CuBr}_4(\text{H}_2\text{O})_2^{2-}$ with little evidence for chain formation of the latter. Whether real disagreement exists among the results for CuBr_2 solutions depends strongly on the confidence that can be attached to the absolute coordination numbers. Clearly the existing results need to be tested against various models for speciation, and improved measurements made.

Among the cations considered here, ZnBr_2 solutions show the most clear cut tendency to form long-range ordered structures. The linked ZnBr_4 tetrahedra reported persist in ethyl acetate²⁰ in which the dielectric constant is over an order of magnitude lower.

In all of the above discussion of the formation of ordered structures or complexes in solutions, it is clear that the ordering is dynamic in nature

to a lesser or greater degree. EXAFS and the diffraction techniques measure the time average of this dynamic structure, which means that all states of the evolution of the structure are factored in with weights proportional to the time spent in each state. If the lifetime of a particular configuration of atoms is long compared to the time it takes to form itself out of randomly associated atoms, then EXAFS or diffraction can give a fairly accurate picture of the structure because the average pair distribution function will reflect that of the quasi-stable configuration. If this pair distribution function is reasonably symmetric, then analysis of the data with the assumption of a Gaussian distribution will give accurate results.^{5,21} This is the procedure that has been universally applied in solution EXAFS work to date. The determination of first sphere bond lengths is probably a good example of this situation, because of the generally good agreement between hydrated crystals and solutions, and among EXAFS and the diffraction techniques. On the other hand, an associated configuration having only very transitory existence, for which the coordinating atoms spend a large fraction of the time moving into and out of position, will exhibit a very asymmetric time average pair distribution function which does not reflect a bonding situation at all. Unless this is accurately taken into account, the EXAFS analysis will emphasize the distance of closest approach, and underestimate the bond lengths in the stable configuration, as discussed by Eisenberger and Brown.⁵ Such an effect may be operating in the case of the second sphere Ni-Cl distance measured for NiCl_2 solutions of 3.1 Å,¹⁴ because this bond length seems unreasonably short.¹²

Although the present discussion emphasizes the study of inorganic solutions by EXAFS spectroscopy, other important applications of EXAFS to solutions also exist. These include the large application area of biochemistry,²² and homogeneous catalysis.^{9,23,24}

APPLICATIONS TO CATALYSTS

The study of catalyst materials has formed one of the major application areas for EXAFS spectroscopy. Because this field is very large, and extensive reviews exist, only catalysis on solids,²⁵ or heterogeneous catalysis, and the contributions of EXAFS spectroscopy will be discussed here. These have also been reviewed recently, e.g. by Lytle et al.²⁶ and Lee et al.²⁷

Supported metal catalysts²⁸ form the main area of application of EXAFS. Here a fortunate combination of circumstances makes EXAFS a probe very well suited to the application. For example, metal atom concentrations are usually low, often below 1 wt. % in a low-Z matrix such as alumina, silica or a zeolite. The inherent sensitivity and spectroscopic element specificity of EXAFS enable the metal properties to be studied without significant interference from the support. In addition, catalysis studies often demand in situ measurements, while the catalyst is treated by temperature cycling and/or exposure to gas environments. This is possible with EXAFS because the x-ray energies involved permit the use of reasonable window and sample cell structures. Such an apparatus has been described by Lytle et al.^{26,29} In addition the speed of measurement, especially when synchrotron radiation is employed, is sufficient for a catalyst to be maintained in a stable state long enough for analysis.

The structural properties of the metal atoms depend greatly on the dispersion, or fraction of metal atoms exposed at the surface of a catalyst particle. Typically, supported metal catalysts having dispersions greater than ~0.5 correspond to particle sizes below ~20 Å and contain fewer than 100 atoms. Clearly such a configuration would be expected to depart from bulk structural and electronic properties, especially when there is interaction with the electronegative support and chemisorption of reactant and product molecules.

The contribution of EXAFS spectroscopy has been to make possible measurement of structural parameters including bond lengths, coordination numbers, disorder parameters and degree of bonding interaction to the support. In addition to the details available in the EXAFS spectrum, much can be deduced from analysis of the near-edge portion of the x-ray absorption spectrum,²⁹ especially the valence state of the catalyst metal atoms. While beyond the scope of this discussion, it is notable that the near edge structure that is measured simultaneously with the EXAFS carries information of comparable importance.

Several EXAFS studies of Pt, Os, Ir, and Ru on both silica and alumina supports³⁰⁻³² illustrate typical procedures. Catalysts were reduced in situ in flowing H₂ at ~425°C, followed by cooling in H₂ to 100°K for measurement of the x-ray absorption spectrum. Measurement was made by the absorption technique, which provided sufficient sensitivity for the 1 wt. % or greater metal loadings studied. Analysis procedures have been described extensively elsewhere;^{26,31,33} they employed the single scattering EXAFS equation with the assumption of small disorder (see below). A nonlinear least squares procedure fitted the model EXAFS function to the Fourier filtered and k^3 weighted data. Reference functions for the backscattering amplitude and the phase function were deduced from measured EXAFS spectra for appropriate metal or solid compound reference materials. Results showed the reduction in nearest neighbor coordination number that would be expected for highly dispersed material, typically about 60% of the bulk value. Trends in the coordination numbers with different catalysts at the same loading suggest important limitations in the use of chemisorption isotherms in determining dispersion in catalysts.³¹ Nearest neighbor bond lengths were found to agree with those of bulk metals within an uncertainty of 0.01 Å, but a tendency to show smaller

bond lengths is suggested. Finally, the disorder measured for these materials at 100°K exceeded that of the bulk metals by a factor of 1.4-2. To these quantitative factors can be added valuable qualitative information such as the changes observed in the appearance of the Fourier transforms of the EXAFS spectra due to oxidation and reduction cycles and temperature processing. An example is given in Fig. 1, in which reduced, O₂-chemisorbed and oxidized states of a Ru catalyst are compared to Ru metal and RuO₂. Numerous other EXAFS studies of this type have been reported.³⁴⁻³⁸ These examples include metal-oxide catalysts, multi-component systems, as well as alloy catalysts.

One important application of the structural data derived from these studies is to estimate the type of structures represented by the small metal clusters. One approach has been that of Greegor and Lytle,³⁹ who measured coordination numbers for first, second, and third nearest neighbors in several catalyst metals. Ratios of these values to the corresponding coordination numbers for the same metals in bulk were then compared to values expected from models corresponding to particle sizes deduced from chemisorption measurements of dispersion. Models were made for various shapes, e.g. spheres, cubes, or disks. Results favored disk-like structures for Os, spheres for Cu, Ru, and Ir, and mixed shapes for Pt.

EXAFS derived results for small Pt particles caged in zeolite^{40,41} have been compared with the extensive literature⁴² describing the stability and structure of small particles. The Pt particles had mean sizes of ~12 Å. Particles analyzed under vacuum exhibited a strong contribution (~1/3) due to a form having reduced bond length, as would be expected for icosahedral particles. This result would be in accord with the expected stabilization of small clusters having 155 atoms into icosahedra.

Marques and Sandstrom are currently studying the temperature dependence of the structure of supported Pt catalysts, and observe a temperature dependent

bond length reduction for highly dispersed (~ 0.9) samples.⁴³ These particles are expected to have average dimensions $< 10 \text{ \AA}$. Average disorder is found to be 1.5 to 2 times the bulk disorder, and exhibits the same temperature dependence as the bulk. It is thought that the temperature dependent contraction is an effect of the added disorder, possibly associated with the presence of icosahedral and fcc particles. This is suggested by the behavior of the phase of the EXAFS oscillations, which show a systematically increasing phase lag at higher k-values, increasing with temperature. This is similar to the disorder effects described in Zn by Eisenberger and Brown.⁵ Modeling of the effective pair distribution functions expected for such systems is being carried out. Clearly, these systems are examples of high disorder, where the low-disorder EXAFS equation must be applied with care.

DATA ANALYSIS

The following discussion will describe techniques in common use for treatment of EXAFS data and determination of structural parameters. Both pretreatment, that is extraction of the EXAFS spectrum from the raw x-ray absorption data, and analysis of the EXAFS spectrum will be discussed. Emphasis will be placed on the practical implementation of these analysis methods on a small minicomputer system. For example, all of the procedures to be described are carried out by the author on a 16-bit minicomputer (Digital Equipment Corp. LSI-11/23) having 256 kilobytes of main memory and 1 megabyte of flexible disk storage. Graphic display of data is via a direct view storage tube graphic terminal (Tektronics Inc.).

Spectrum Acquisition

A discussion of experimental techniques for EXAFS is beyond the scope of this article, but data analysis considerations obviously enter in planning

for data acquisition. Most EXAFS spectra are measured by sequentially measuring the x-ray absorption at a series of predetermined settings of a crystal monochromator. Ordinarily, a computer sets the monochromator via a stepping motor drive and also operates detectors, stores the data and performs other essential functions on-line to the experiment. Control programs in common use (e.g. that of Kirby⁴⁴) provide for scanning over a predetermined range in step number or Bragg angle θ , and for subdivision of this range into several subranges for which the spacing of the individual data points can be independently set.

The problem, then, is to decide on the size of the overall scan region, the positions of the breakpoints between the subregions, and the spacing of the data points in each subregion. Several considerations apply. In the x-ray energy range below the absorption edge several hundred eV are ordinarily scanned to determine the trend of the background absorption. Here resolution is not important so that the Bragg angle intervals between data points can correspond to fairly large energy intervals (e.g. 25 eV). In the region immediately below and above the absorption edge, near-edge structure may be important. In any case a careful determination of the edge position is needed for calibration purposes, indicating a fine scan over this region. Here, within ~25-40 eV of the absorption edge, the data points may have spacings as close as 1 eV or less, depending on the resolution of the spectrometer. The EXAFS region starts just above the absorption edge and extends to 1000-1500 eV above the edge, depending on how rapidly the oscillations damp out, and whether other features limit the scan. For example, an L_{III} edge scan is usually limited by the position of the L_{II} edge. The full range of the EXAFS region scan can be subdivided into three or more subregions.

Planning of these regions should be based on the ultimate objective of displaying the data in k (wave vector) space, where $k = \sqrt{2m(\hbar\omega - E_K)}/\hbar$. To facilitate accurate interpolation of the data onto an equally spaced k -grid, planning should reduce the variation in k -spacing between data points to the greatest extent possible. A useful strategy is to choose the limits of the subregions of the EXAFS region to provide for the same fractional change in k in each subregion. This is accomplished by letting

$$\frac{k_{i+1}}{k_i} = \left(\frac{k_{\max}}{k_{\min}}\right)^{1/n},$$

where k_i is the starting point and k_{i+1} the end point of the i th subregion, $k_{\min}$ and $k_{\max}$ are the starting and ending points of the whole EXAFS region, and n is the number of subregions. During a scan, the fact that the data points are spaced at fixed θ intervals $\Delta\theta$ means that the k -spacing between data points varies across each subregion according to $\Delta k = (dk/d\theta)\Delta\theta$. This effect can be minimized by choosing the median Δk value

$$\Delta k_m = \frac{1}{2} \left| \left(\frac{dk}{d\theta}\right)_{\theta_i} + \left(\frac{dk}{d\theta}\right)_{\theta_{i+1}} \right| \Delta\theta$$

the same in each subregion. A value of $0.05 \text{ \AA}^{-1}$ gives a suitable number of data points. The above considerations could be eliminated by writing a control program that scans at approximately equal k -intervals in the EXAFS region. To date the advantage of this approach has not been sufficient to motivate its implementation, for example, at the SSRL facility.

Background Subtraction

Following calculation of the x-ray photon energy values for the data points from Bragg's formula, the next step of data analysis is to carefully calibrate the spectrum by setting the origin of the photoelectron energy scale at the position of the absorption edge of a suitable pure reference substance

(e.g. a metal foil) for which a spectrum was measured concurrently with the material being analyzed.

Subsequently, the smooth background can be subtracted to isolate the EXAFS oscillations. This operation is better carried out in E-space (E = photoelectron energy) than in k-space, because of excessive curvature that appears at low k-values in a k-space display. Some care must be taken in choosing the end points of the EXAFS region for this operation, especially the low end, to avoid influencing the smooth background by including non-EXAFS sharp features near the absorption edge. A cubic smoothing spline algorithm works very well for approximating the smooth background.^{27,45} The spline can be calculated over equal or varying size subregions to control its "stiffness" to suit the shape of the background. Usually three equal subregions are satisfactory. The smoothing must of course be carried out on data points having equally spaced E-values, requiring interpolation. Cubic interpolation splines,⁴⁵ which are fast and accurate, are very satisfactory for this purpose. At this stage, the interpolation need only be carried out for calculation of the smooth background. Subtraction of the smooth background can be made at the E-values of the original data points, so that the approximately uniform k-spacing is retained and the effect of the interpolation is not propagated forward.

An example of smooth background subtraction is given in Fig. 2. Note that the height of the absorption edge jump is determined at this stage by extrapolation of the smooth background, and used to normalize the EXAFS amplitude.

The data are now ready to be replotted in k-space. The parameter E_0 (the background potential) could be introduced at this point as a correction to the scale of E. It seems preferable to leave this to a separate analysis step, and determine k from $k = \sqrt{2mE}/\hbar$. An example of the resulting EXAFS

spectrum, corresponding to the absorption spectrum given in Fig. 2 is shown in Fig. 3.

Fourier Transform

The Fast Fourier Transform (FFT) algorithm for discrete Fourier transform is efficient and easily programmed.⁴⁶ It can be applied directly to the k-space spectrum, in which case the input to the FFT is a real vector, or the EXAFS spectrum can first be multiplied by $\exp[-i\phi(k)]$ to remove the effect of a known phase function $\phi(k)$, as will be discussed later. In the latter case, the input to the FFT is a complex vector and requires twice the storage area in computer memory. The size of the FFT determines the resolution in transform space, (r-space) because the spacing between adjacent r-space harmonics, Δr , is related to the full k-range represented by the input vector to the FFT by $\Delta r = \pi/k_f$, where the full input k-range runs from zero to k_f . (To preserve the phase information in the EXAFS spectrum, the FFT input vector should start with $k = 0$; zeros can pad the vector out to the start of the data.) To achieve reasonable resolution in r-space, the input k-range must be made considerably larger than the range of the EXAFS spectrum by padding the input vector with zeros from the end of the data to k_f . The size of the transform chosen and k_f will fix the required resolution of the data in k-space according to $\Delta k = k_f/N$, where Δk is the size of the required k-space grid, and N is the transform size (usually a power of 2). For example, a 4096 point transform of data padded out to $96 \text{ \AA}^{-1}$ will require interpolation of the data on a k-space grid at intervals of $0.0234 \text{ \AA}^{-1}$. The resulting Fourier transform will have an r-space grid interval of $0.0327 \text{ \AA}$.

Before transforming, the k-space data are often multiplied by powers of k to provide a more uniform weighting across the spectrum. In addition,

the portions of the data to be transformed are usually selected by a window function to take the amplitude smoothly to zero at the end points. This is for the purpose of reducing termination ripples, or leakage of the corresponding harmonics to adjacent portions of the spectrum in r -space.⁴⁶ Various windows are used in digital signal processing, including Hanning, Gaussian, and modifications that only effect a few percent at the ends of the k -range. These have been discussed extensively.^{27,46,47}

Figure 4 shows the Fourier transform of the Pt data of Figs. 2 and 3, taken without any correction for the effect of the phase function $\phi(k)$.

Care must be taken not to interpret the Fourier Transform as a radial distribution function, because of nonlinear interplay between the disorder parameter σ and both the height and width of the Fourier transform peak. A study of this effect has been reported by Greigor and Lytle⁴⁸ for the case of Cu by comparing data taken over a wide range of temperatures for which the disorder was accurately known.

Inverse Transform

To isolate the EXAFS contribution due to a single feature in the Fourier transform, the inverse transform of the corresponding portion of the r -space spectrum can be taken. In doing this, it must be remembered that the r -space harmonics contained in the lower half of the transform also appear folded into the upper half by the phenomenon known as aliasing.⁴⁶ The entire upper half transform, or "fold," must be set to zero along with the harmonics outside the selected feature in the lower half. Both the real and imaginary parts of the complex transform are set to zero outside the selected range. A rectangular window function can be used to select the desired feature if the cutoff points correspond to harmonics of small magnitude, but smooth window

functions are sometimes used. The resulting complex vector is then used as input to the inverse FFT, resulting in a complex vector in k-space. The real part of this result represents the isolated EXAFS function corresponding to the feature selected in r-space. The overall phase $\phi(k)$ of this EXAFS function is given by adding $\pi/2$ to the argument of the complex k-space vector. The $\pi/2$ term is associated with setting the "fold" components to zero in r-space.²⁷ An inverse transform (real part) of the major feature of the Fig. 4 Fourier transform is shown in Fig. 5.

Phase Functions

The total phase of the Fourier filtered EXAFS spectrum corresponds to $\Phi(k) = 2kr + \phi(k)$, where r is the bond length giving rise to the selected Fourier transform feature. If r is known, as for a reference substance, then $\phi(k)$ can be calculated directly. The only ambiguity is the effect of E_0 , which determines the k scale according to $k = \sqrt{2m(E-E_0)}/\hbar$. A change in the E_0 value by ΔE_0 modifies the phase function^{49,50} according to

$$\phi'(k') \approx \phi(k) + 2mr\Delta E_0/k\hbar^2$$

where

$$k' = (k^2 - 2m\Delta E_0/\hbar^2)^{1/2}.$$

In the case of a reference substance for which r is known, it may be desirable to find the E_0 value that gives the best agreement between the empirically determined phase functions and theoretical phase functions.⁵⁰ Alternatively, if a theoretical or empirical reference phase function is available, both E_0 and r can be adjusted in calculating $\phi(k)$ from $\Phi(k)$ to fit the phase of the unknown substance to that of the standard.

This is the phase fitting technique referred to earlier.⁹ It is equivalent to the "constant r " method described by Martens et al.,⁴⁷ for which E_0 is adjusted to give a constant value of

$$r(k) = [\phi(k) - \phi(k)]/2k$$

over the widest k -range, with the resulting constant value to be assigned to the bond length.

Figure 6 shows $\phi(k)$ for the Pt metal first neighbor bond in comparison with the theoretical calculation of Teo and Lee.⁵⁰ Here r was fixed at the crystallographic value at 100°K of 2.769 Å, and E_0 was adjusted for best fit, giving a value of 5.35 eV.

Fourier Transform Modified by Phase Function

When the phase function $\phi(k)$ is known empirically as described above, or is available from theory, it is an advantage in some situations to calculate a modified Fourier transform of the EXAFS spectrum by first multiplying the data by $\exp[-i\phi(k)]$. Transforming the resulting complex vector is then equivalent to transforming the data with respect to the full phase argument.^{49,51} This type of transform has the advantage of providing a criterion for selecting E_0 , as shown by Lee and Beni.⁴⁹ When E_0 is adjusted so that $\phi(k)$ is accurate for the given spectrum, the imaginary part and magnitude of the transform should align at the correct bond distance. Note that this procedure is only useful when the EXAFS oscillations are all due to the same absorber-scatterer pair (or at least when features in the Fourier transform due to different absorber-scatterer pairs are well separated), since only one phase function can be removed at a time.

Figure 7 shows the phase removed transform of the Pt data of Fig. 3, for which the theoretical phase function shown in Fig. 6 was used. In Fig. 7 each coordination distance is represented by a single peak with minor side lobes (due to the k -dependence of the amplitude function and the windowing used). In contrast, the complicated behavior of $\phi(k)$ for Pt-Pt causes the normal Fourier transform (Fig. 5) to have extremely complicated structure. The phase removed transform has proved to be useful in studies of Pt catalysts, because it greatly aids in the isolation of the first neighbor peak from the second neighbor and the Pt-O coordinations due to the support. Subsequent inverse transforms are ready for analysis by curve fitting without use of $\phi(k)$, because the phase of the resulting inverse transform represents only any differences between the material being studied and the reference. This residual is significant in the analysis of disorder effects as discussed in the example of Pt catalysts.⁴³

Curve Fitting

The real part of the inverse transform is the input for the model function curve fitting techniques that are widely used to extract bond distances, coordination numbers and disorder parameters. The model function for k -space analysis has usually been the familiar EXAFS equation that applies in the limit of small disorder:

$$\chi(k) = \sum_j A_j(k) \sin[2kr_j + \phi_j(k)] .$$

Here the sum extends over all the coordination shells (radii r_j) included in the inverse transform and $\phi_j(k)$ is the phase function for the j th shell. The amplitude $A_j(k)$ is

$$A_j(k) = (N_j/k r_j) |f_j(k, \pi)| \exp(-2k^2 \sigma_j^2) ,$$

where N_j , f_j , and σ_j are, respectively, the coordination number, backscattering amplitude and disorder parameter for the j th shell.

Curve fitting procedures for the EXAFS equation have been reviewed in detail,^{27,33} and also discussed in the specific applications of solutions¹⁴ and catalysts.²⁶

Other Techniques

The above summarizes analysis procedures that have been widely applied, especially to solutions and catalysts. Many variations and alternative methods are in common use, especially for disordered systems. Examples include analysis of beats in the EXAFS oscillations to resolve near bond distances,⁵² fitting of model functions to the r -space transform of the data,⁵³ and various analyses of the phase and amplitude effects of disorder.^{5,43,51,54,55}

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TABLE I

Solute	Concentration (Moles/liter)	Coordination	Bond Length (Angstroms)	Reference
CuBr ₂		Cu-O	1.97 ± 0.08	4
		Br-O	3.14 ± 0.1	4
Ni(NO ₃) ₂ ·6(H ₂ O)	0.1 M	Ni-O	2.05	8
Ni(NO ₃) ₂ ·6(H ₂ O)	0.1 M	Ni-O	2.06 ± 0.01	9
Co(NO ₃) ₂ ·6(H ₂ O)	0.1 M	Co-O	2.08 ± 0.01	9
Cr(NO ₃) ₃ ·6(H ₂ O)	0.1 M	Cr-O	2.01 ± 0.01	9

TABLE II

Solute	Concentration	Method	Principal Results	Reference
NiCl_2	4 M and 2 M	XRD	Ni^{2+} ions fully hydrated. $\text{Ni-H}_2\text{O}$ distance: 4 M, 2.062 Å; 2 M, 2.069 Å.	10
NiCl_2	2.95 M	XRD	Ni^{2+} ions fully hydrated, or up to 50% contribution of $\text{Ni}(\text{H}_2\text{O})_5^+ \text{Cl}^-$.	11
NiCl_2	1.96 and 3.88 M	XRD	Ni^{2+} ions fully hydrated, but evidence presented for sharing of water molecules by neighboring anion and cation coordination shells. $\text{Ni-H}_2\text{O}$ distances: 1.96 M, 2.063 Å; 3.88 M, 2.068 Å.	12
NiCl_2	0.086 - 4.41 M (In D_2O)	ND	Ni^{2+} ions fully hydrated. At highest concentrations Ni-O distance is 2.07 Å. Angle between D_2O plane and Ni-D axis $\sim 45^\circ$ at highest concentrations, decreasing to zero at lowest concentration.	13
NiCl_2	2.78 and 3.74 M	EXAFS	Ni^{2+} ions fully hydrated. Ni-O distances: 2.78 M, 2.06 Å; 3.74 M, 2.07 Å. Evidence for Cl^- in second coordination sphere of Ni^{2+} .	14
NiCl_2	0.5 and 4.0 M	EXAFS	Very little or no Ni-Cl bonding.	15
NiCl_2	0.21 - 4.2 M	Raman	At highest concentrations, $\sim 50\%$ of Ni^{2+} in NiCl_4^{2-} complexes.	16

TABLE II (continued)

Solute	Concentration	Method	Principal Results	Reference
NiBr ₂	0.4 and 4.0 M	EXAFS	Little or no Ni-Br bonding.	15
CuCl ₂	2.95 M	XRD	Cu ²⁺ coordinated by average of 1.2 equatorial Cl ⁻ ions, 2.8 equatorial water molecules, and identity of axial coordination ambiguous.	11
CuCl ₂	3.3 and 4.4 M*	XRD	3.3-3.6 Cl ⁻ ions in primary coordination sphere of Cu ²⁺ .	17
CuCl ₂	0.05 and 4.86 M	EXAFS	Cu-Cl bonding evident at high concentration.	15
CuBr ₂	0.05 - 4.5 M	EXAFS	50% of Cu ²⁺ ions bound in linked planer CuBr ₄ structure as in crystal.	15, 18
CuBr ₂	3.3 and 4.4 M*	EXAFS	Multiple mononuclear CuBr _n (H ₂ O) _{2-n} complexes.	19
ZnBr ₂	8.08 M	EXAFS	Zn ²⁺ in linked ZnBr ₄ tetrahedra similar to crystal.	15
ZnBr ₂	0.05 - 5.3 M (in ethyl acetate)	EXAFS	Zn ²⁺ in linked ZnBr ₄ tetrahedra similar to crystal.	20

*Concentrations shown for stoichiometric solutions. Study also investigated non-stoichiometric solutions.

Figure 4. Magnitude of the Fourier transform of the Pt metal EXAFS oscillations shown in Fig. 3 after weighting by k . Radius scale in $\text{\AA}$. Data in the range $4.4 - 14.3 \text{ \AA}^{-1}$ have been selected for transform by a half-cosine bell window function applied to 10% of the above range at both ends of the range. The 4096 points transformed correspond to a full k -range of $96 \text{ \AA}^{-1}$.

Figure 5. Inverse Fourier transform (real part) of the complex transform for which the magnitude is shown in Fig. 4, after setting to zero all harmonics outside the vertical bars on Fig. 4. The result corresponds to the first shell contribution in Pt metal at 100°K . The effect of weighting by k and windowing have not been removed from the inverse transform. Wave vector scale (k -scale) same as Fig. 3.

Figure 6. Comparison of empirical and theoretical phase function for Pt metal at 100°K . Solid curve: Phase of the inverse transform oscillations shown in Fig. 5 determined as described in text, minus $2kr$ for $r = 2.769 \text{ \AA}$. Dotted curve: Theoretical calculation for Pt absorber ($\ell=2$) and Pt scatterer.⁵⁰ Multiples of 2π have been used to shift the curves into alignment. E_0 has been adjusted for the empirical phase function to give best agreement, resulting in $E_0 = 5.35 \text{ eV}$. Wave vector scale (k -scale) same as Fig. 3.

Figure 7. Magnitude (envelope curve) and imaginary part of phase removed Fourier transform of Pt metal EXAFS oscillations shown in Fig. 3, using theoretical phase function shown in Fig. 6, and E_0 shift of 5.35 eV . Radius scale same as Fig. 4.

CAPTIONS FOR FIGURES

Figure 1. EXAFS spectra (a,b,c,d, and e) and corresponding Fourier transforms (A,B,C,D, and F) for Ru: (a,A) 1% Ru on SiO_2 catalyst, reduced in H_2 ; (b,B) after exposure to 1011 pa O_2 at 25°C ; (c,C) after exposure to O_2 at 400°C ; (d,d) Ru metal; (e,E) RuO_2 . From Ref. 26.

Figure 2. X-ray absorption spectrum measured at the Pt-L_{III} edge, for Pt metal (2.5 μm foil) at 100°K . Energy scale relative to edge energy of 11563.7 eV. Absorption scale given by $\ln(I_0/I)$, where I_0 and I represent the incident and transmitted beam detector signals respectively. The smooth curve drawn through the data was generated by a cubic smoothing spline calculated on three equally spaced regions delimited by the two crosses drawn on the data. The spacing of the two crosses to the left of the edge gives an estimate of the absorption edge jump obtained by extrapolation of the spline curve to a point (upper cross) directly above the pre-edge absorption minimum (lower cross).

Figure 3. EXAFS oscillations vs photoelectron wave vector $k \text{ \AA}^{-1}$, for Pt metal data shown in Fig. 2. The ordinate χ is given by the difference of the x-ray absorption and the spline curve shown in Fig. 2, divided by the absorption edge jump. The wave vector scale has been calculated from $k = \sqrt{0.263E}$, where E is the energy scale in Fig. 2.

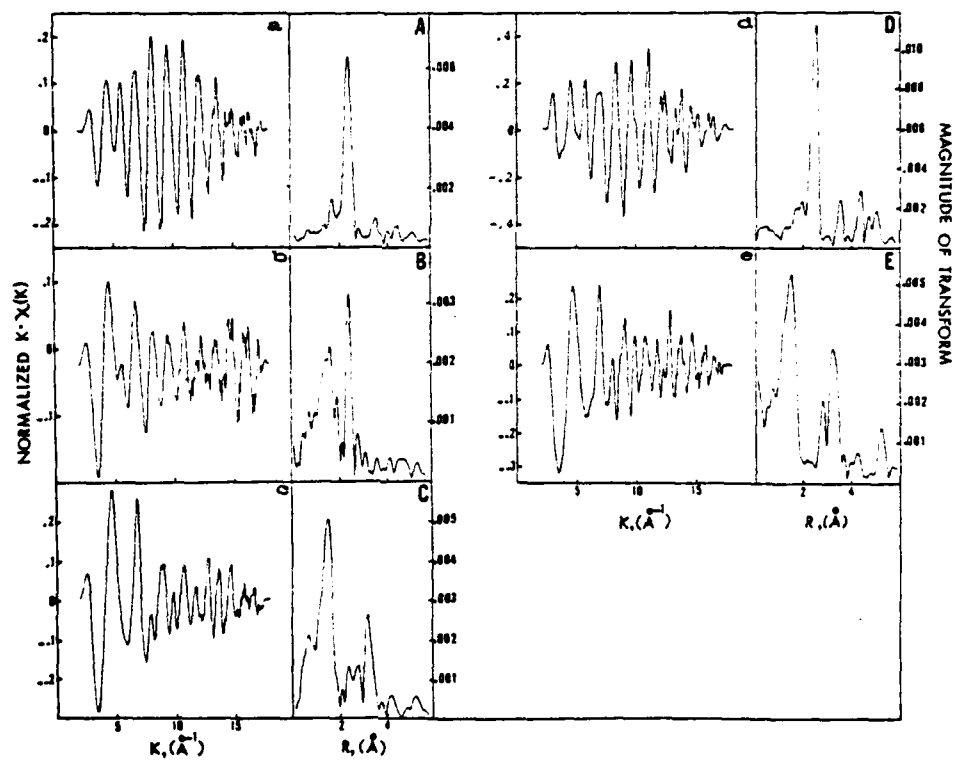


Fig. 1

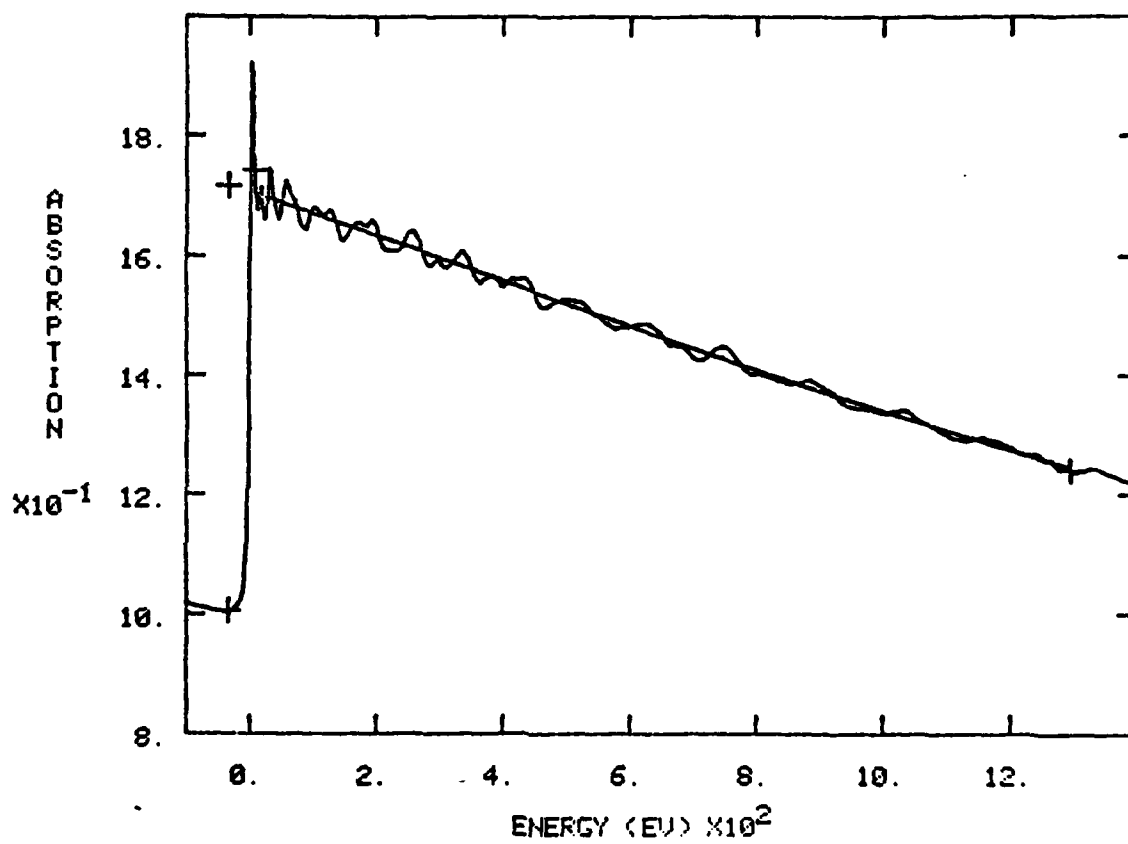
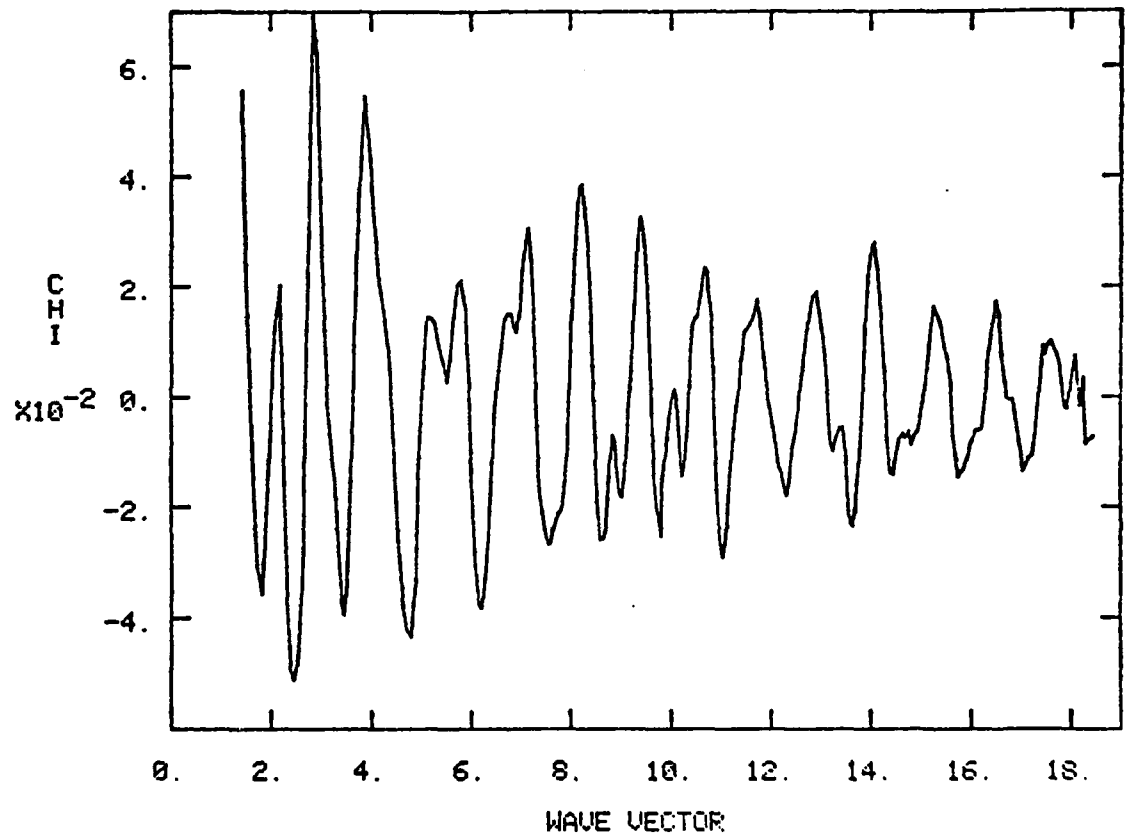
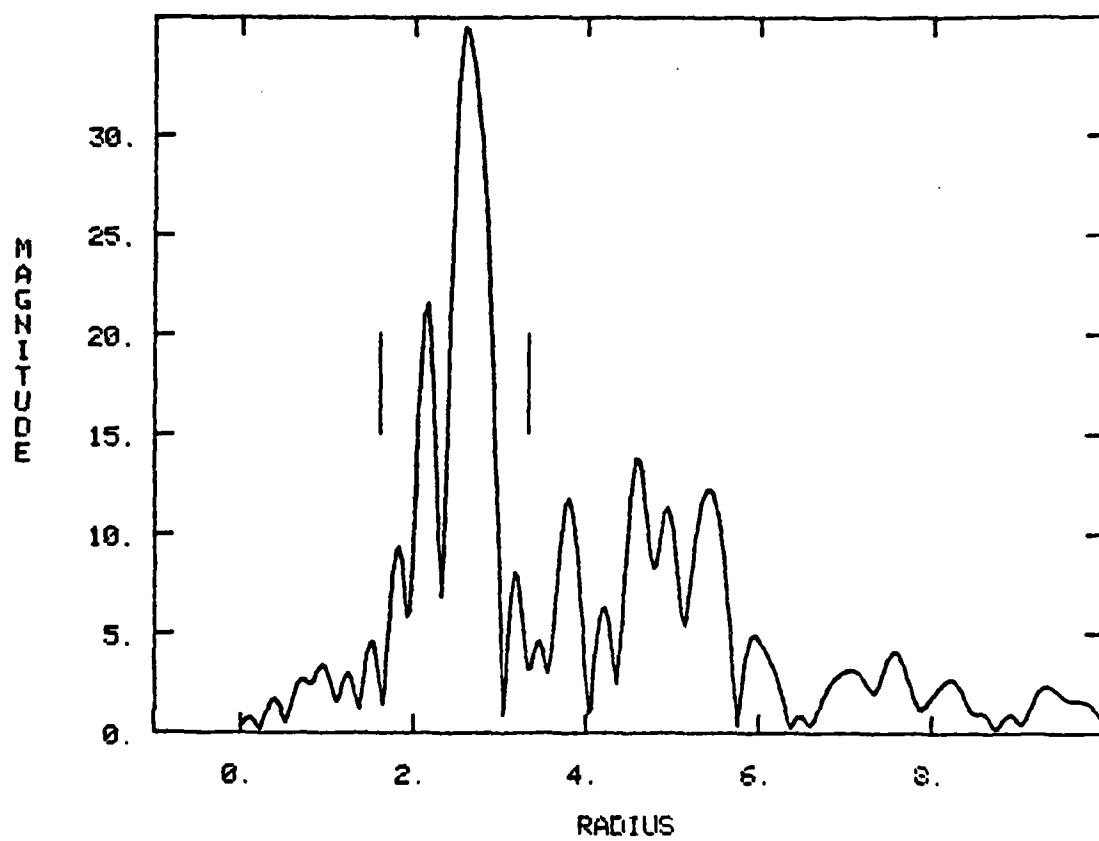
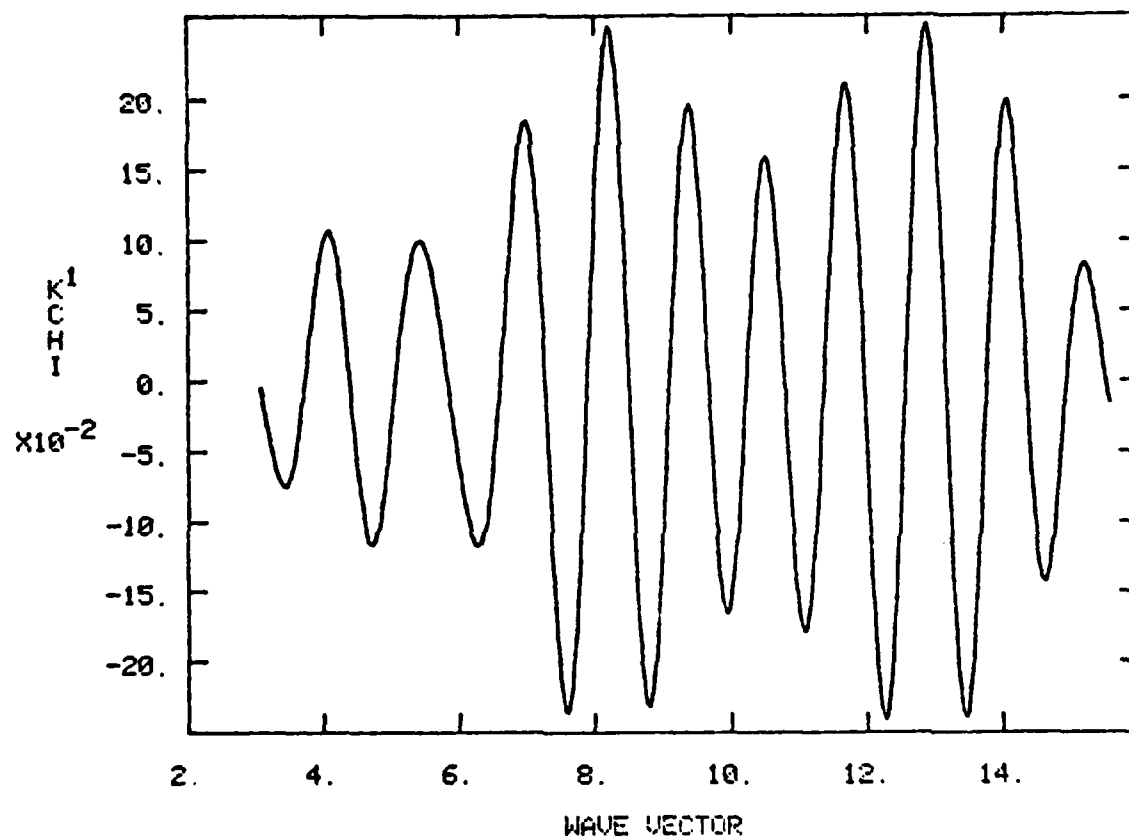
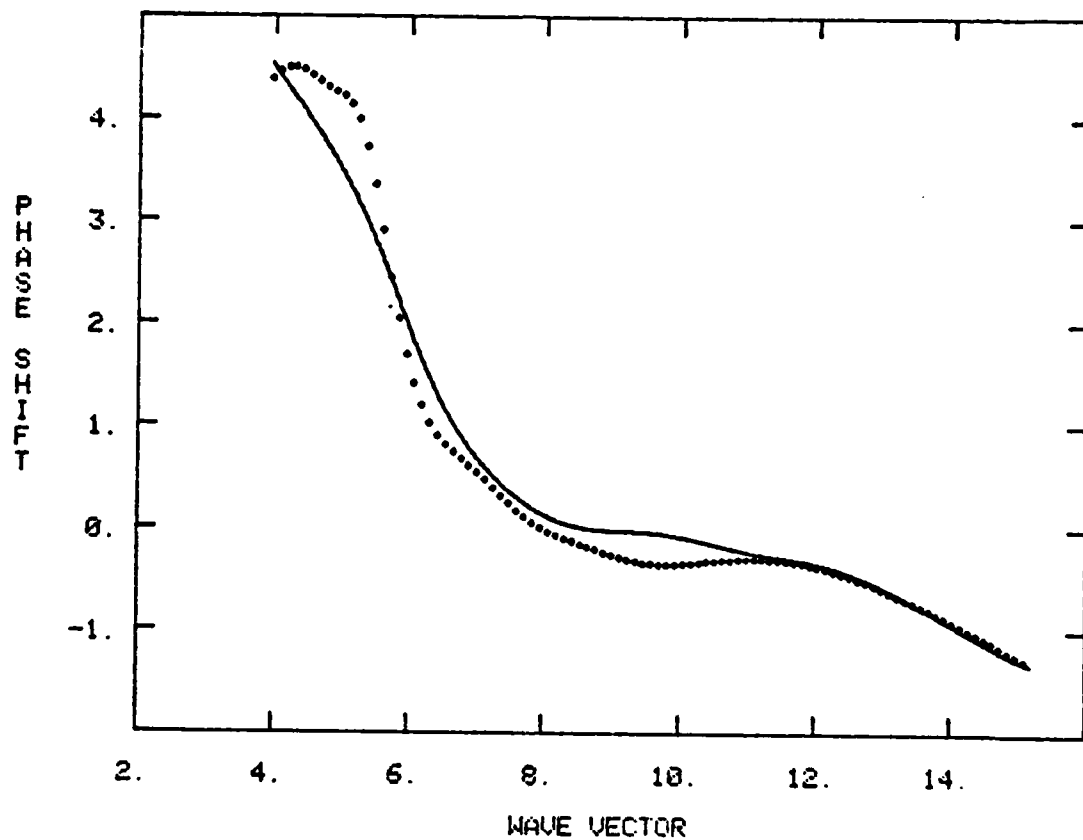


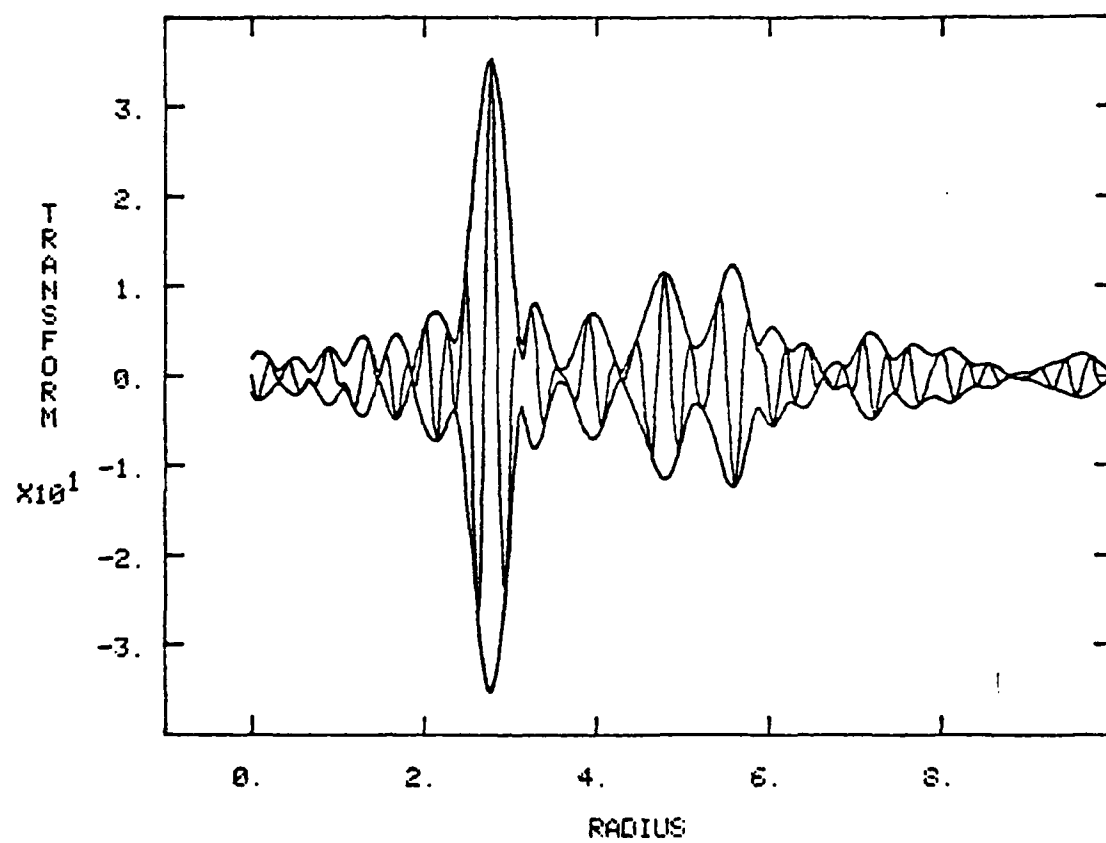
Fig 2











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